

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/653,670	REID, LAURA	
Examiner	Art Unit	
Quynh H. Nguyen	2642	

	SEARCHED			
Class	Subclass	Date	Examiner	
379	33 37 93.01 93.07 106.01 221.01	6/28/2005	QN	
379	221.02	6/28/2005	QN	
379	221.03	6/28/2005	QN	
379	221.14	6/28/2005	QN	
379	207.14	6/28/2005	QN	
379	211.01	6/28/2005	QN	
379	211.02	6/28/2005	QN	
379	212.01	6/28/2005	QN	
370	351	6/28/2005	QN	
370	352	6/28/2005	QN	
370	353	6/28/2005	QN	
370	354 ·	6/28/2005	QN	
370	355	6/28/2005	QN	
370	356	6/28/2005	QN	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
·	DATE	EXMR		
searched: east	6/28/2005	QN		
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